

Search Notes**Application/Control No.**

10/731,757

Examiner

David Buttner

Applicant(s)/Patent under Reexamination

YANG ET AL.

Art Unit

1712

SEARCHED

Class	Subclass	Date	Examiner
523	451	5/16/2005	DB
524	96	5/16/2005	DB
524	97	5/16/2005	DB
525	65	5/16/2005	DB
525	67	5/16/2005	DB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	5/16/2005	DB
inventor search	5/16/2005	DB
McGinty for continuity questions	5/16/2005	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner